

100313 Low Power Quad Driver

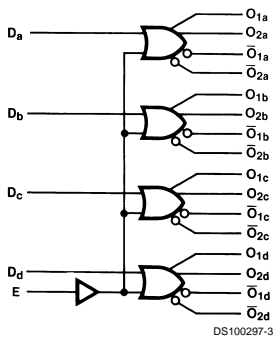
General Description

The 100313 is a monolithic quad driver with two OR and two NOR outputs and common enable. The common input is buffered to minimize input loading. If the D inputs are not used the Enable can be used to drive sixteen 50Ω lines. All inputs have 50 kΩ pull-down resistors and all outputs are buffered.

Features

- 50% power reduction of the 100113
- 2000V ESD protection
- Pin/function compatible with 100113 and 100112
- Voltage compensated operating range = -4.2V to -5.7V
- Standard Microcircuit Drawing (SMD) 5962-9673201

Logic Symbol

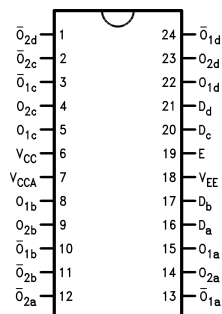


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Pin Names	Description
D_a - D_d	Data Inputs
E	Enable Input
O_{1a} - O_{1d}	Data Outputs
\bar{O}_{1a} - \bar{O}_{1d}	Complementary Data Outputs

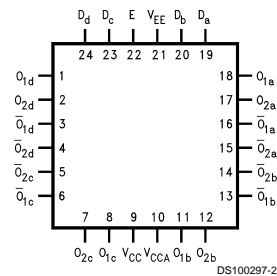
Connection Diagrams

24-Pin DIP



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24-Pin Flatpak



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Absolute Maximum Ratings (Note 1)

If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/Distributors for availability and specifications.

Storage Temperature (T_{STG})	-65°C to +150°C
Maximum Junction Temperature (T_J)	
Ceramic	+175°C
V_{EE} Pin Potential to Ground Pin	-7.0V to +0.5V
Input Voltage (DC)	V_{EE} to +0.5V
Output Current (DC Output HIGH)	-50 mA
ESD (Note 2)	≥2000V

Military Version DC Electrical Characteristics

$V_{EE} = -4.2V$ to $-5.7V$, $V_{CC} = V_{CCA} = GND$, $T_C = -55^\circ C$ to $+125^\circ C$

Symbol	Parameter	Min	Max	Units	T_C	Conditions	Notes	
V_{OH}	Output HIGH Voltage	-1025	-870	mV	0°C to +125°C	$V_{IN} = V_{IH (Max)}$ or $V_{IL (Min)}$	Loading with 50Ω to -2.0V	(Notes 3, 4, 5)
		-1085	-870	mV	-55°C			
V_{OL}	Output LOW Voltage	-1830	-1620	mV	0°C to +125°C	$V_{IN} = V_{IH (Min)}$ or $V_{IL (Max)}$	Loading with 50Ω to -2.0V	(Notes 3, 4, 5)
		-1830	-1555	mV	-55°C			
V_{OHC}	Output HIGH Voltage	-1035		mV	0°C to +125°C	$V_{IN} = V_{IH (Min)}$ or $V_{IL (Max)}$	Loading with 50Ω to -2.0V	(Notes 3, 4, 5)
		-1085		mV	-55°C			
V_{OLC}	Output LOW Voltage		-1610	mV	0°C to +125°C	$V_{IN} = V_{IH (Min)}$ or $V_{IL (Max)}$	Loading with 50Ω to -2.0V	(Notes 3, 4, 5)
			-1555	mV	-55°C			
V_{IH}	Input HIGH Voltage	-1165	-870	mV	-55°C to +125°C	Guaranteed HIGH Signal for All Inputs		(Notes 3, 4, 5, 6)
V_{IL}	Input LOW Voltage	-1830	-1475	mV	-55°C to +125°C	Guaranteed LOW Signal for All Inputs		(Notes 3, 4, 5, 6)
I_{IL}	Input LOW Current	0.50		μA	-55°C to +125°C	$V_{EE} = -4.2V$ $V_{IN} = V_{IL (Min)}$	(Notes 3, 4, 5)	
I_{IH}	Input HIGH Current	Data Enable	350	μA	0°C to +125°C	$V_{EE} = -5.7V$ $V_{IN} = V_{IH (Max)}$		(Notes 3, 4, 5)
			240	μA	-55°C			
		Data Enable	500	μA	-55°C			
			340	μA	-55°C			
I_{EE}	Power Supply Current	-65	-20	mA	-55°C to +125°C	Inputs Open		(Notes 3, 4, 5)

Note 3: F100K 300 Series cold temperature testing is performed by temperature soaking (to guarantee junction temperature equals -55°C), then testing immediately without allowing for the junction temperature to stabilize due to heat dissipation after power-up. This provides "cold start" specs which can be considered a worst case condition at cold temperatures.

Note 4: Screen tested 100% on each device at -55°C, +25°C, and +125°C, Subgroups 1, 2, 3, 7, and 8.

Note 5: Sample tested (Method 5005, Table I) on each manufactured lot at -55°C, +25°C, and +125°C, Subgroups A1, 2, 3, 7, and 8.

Note 6: Guaranteed by applying specified input condition and testing V_{OH}/V_{OL} .

Military Version AC Electrical Characteristics

$V_{EE} = -4.2V$ to $-5.7V$, $V_{CC} = V_{CCA} = GND$

Symbol	Parameter	$T_C = -55^\circ C$		$T_C = +25^\circ C$		$T_C = +125^\circ C$		Units	Conditions	Notes
		Min	Max	Min	Max	Min	Max			
t_{PLH}	Propagation Delay	0.30	2.00	0.30	1.80	0.30	2.30	ns	Figures 1, 2	(Notes 7, 8, 10, 11)
t_{PHL}	Data to Output									
t_{PLH}	Propagation Delay	0.50	2.40	0.60	2.30	0.60	2.70	ns		
t_{PHL}	Enable to Output									
t_{TLH}	Transition Time	0.30	2.00	0.30	1.90	0.30	2.00	ns		(Note 10)
t_{THL}	20% to 80%, 80% to 20%									

Note 7: F100K 300 Series cold temperature testing is performed by temperature soaking (to guarantee junction temperature equals $-55^\circ C$), then testing immediately after power-up. This provides "cold start" specs which can be considered a worst case condition at cold temperatures.

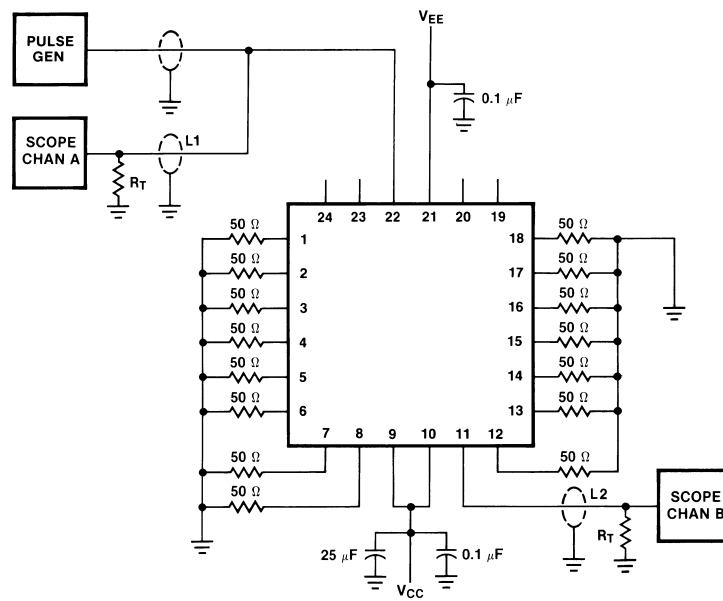
Note 8: Screen tested 100% on each device at $+25^\circ C$, Subgroup A9.

Note 9: Sample tested (Method 5005, Table I) on each manufactured lot at $+25^\circ C$, Subgroup A9, and at $+125^\circ C$ and $-55^\circ C$ temperatures, Subgroups A10 and A11.

Note 10: Not tested at $+25^\circ C$, $+125^\circ C$, and $-55^\circ C$ temperature (design characterization data).

Note 11: The propagation delay specified is for single output switching. Delays may vary up to 150 ps with multiple outputs switching.

Test Circuitry



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Notes:

V_{CC} , $V_{CCA} = +2V$, $V_{EE} = -2.5V$.

L1 and L2 = equal length 50Ω impedance lines.

$R_T = 50\Omega$ terminator internal to scope.

Decoupling 0.1 μF from GND to V_{CC} and V_{EE} .

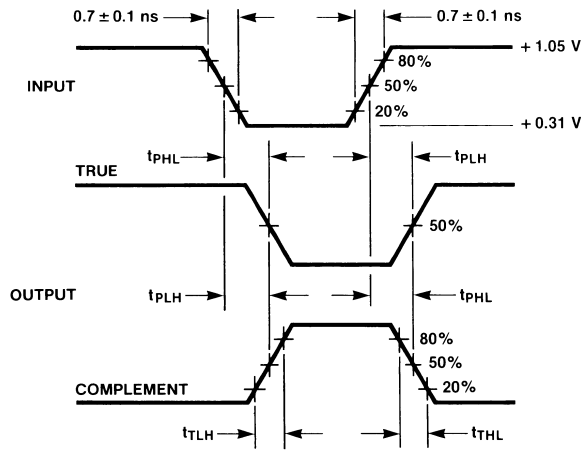
All unused outputs are loaded with 50Ω to GND.

$C_L =$ Fixture and stray capacitance ≤ 3 pF.

Pin numbers shown are for flatpak; for DIP see logic symbol.

FIGURE 1. AC Test Circuit

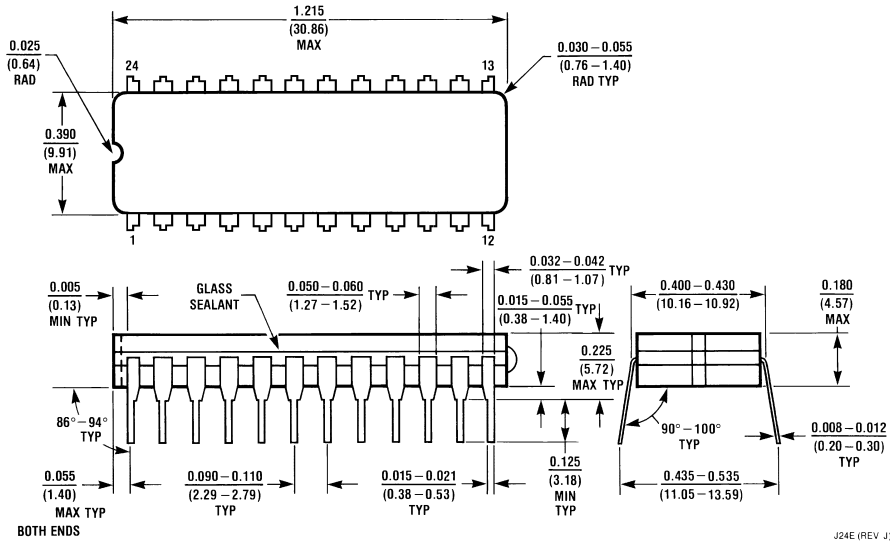
Switching Waveforms



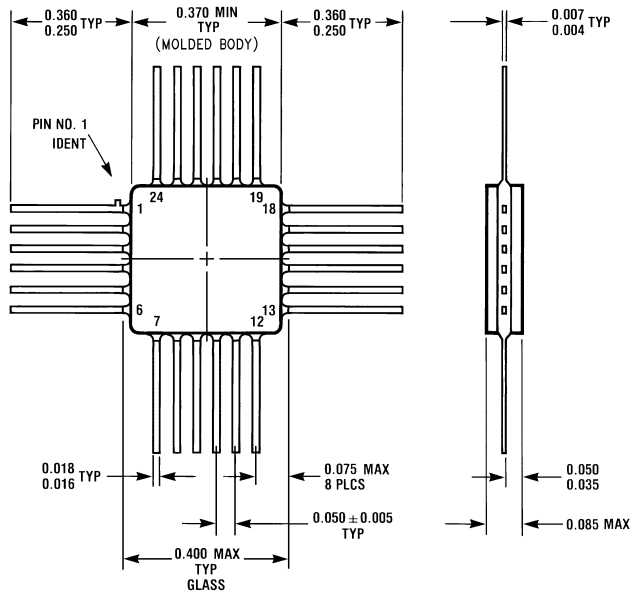
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FIGURE 2. Propagation Delay and Transition Times

Physical Dimensions inches (millimeters) unless otherwise noted



24-Pin Ceramic Dual-In-Line Package (D)
NS Package Number J24E



24-Pin Quad Cerpak (F)
NS Package Number W24B

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100313 **Low Power Quad Driver**

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


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Datasheet

Title	Size (in Kbytes)	Date	 View Online	 Download	 Receive via Email
100313 Low Power Quad Driver	119 Kbytes	4-Sep-98	View Online	Download	Receive via Email

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Package Availability, Models, Samples & Pricing

Part Number	Package		Status	Models		Samples & Electronic Orders	Budgetary Pricing		Std Pack Size
	Type	# pins		SPICE	IBIS		Quantity	SUS each	
5962-9673201QXA	Cerdip	24	Full production	N/A	N/A		50+	\$24.2000	tube of 15
5962-9673201QYA	Cerquad	24	Full production	N/A	N/A		50+	\$27.0000	tube of 14
100313FM-MLS	Cerquad	24	Full production	N/A	N/A		50+	\$260.0000	tube of 14

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